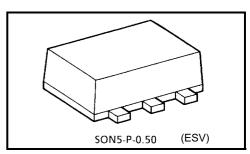
TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC7SZ125AFE

Dual Bus Buffer 3-State Output

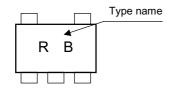
Features

- High output drive: ±24 mA (min) @VCC = 3 V
- Super high speed operation: tpd 2.6 ns (typ.) @VCC = 5 V, 50 pF
- Operation voltage range: $V_{CC (opr)} = 1.8 \sim 5.5 \text{ V}$
- Latch-up performance: ±500 mA or more
- ESD performance: ±200 V or more (JEITA) ±2000 V or more (MIL)
- Power down protection is provided on all inputs and outputs.
- \bullet Matches the performance of TC74LCX series when operated at 3.3 V VCC.

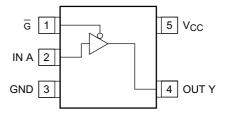


Weight: 0.003 g (typ.)

Marking



Pin Assignment (top view)



Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	-0.5~6	V
DC input voltage	V _{IN}	-0.5~6	V
DC output voltage	V _{OUT}	-0.5~V _{CC} + 0.5	V
Input diode current	I _{IK}	-20	mA
Output diode current	I _{OK}	±20	mA
DC output current	lout	±50	mA
DC V _{CC} /ground current	I _{CC}	±50	mA
Power dissipation	P _D	150	mW
Storage temperature	T _{stg}	-65~150	°C
Lead temperature (10s)	TL	260	°C

Truth Table

Α	Ġ	Y
Х	Н	Z
L	L	L
Н	L	Н

Logic Diagram



Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit
Supply voltage	V _{CC}	1.8~5.5	V
Supply voltage	VCC	1.5~5.5 (Note)	V
Input voltage	V _{IN}	0~5.5	V
Output voltage	V _{OUT}	0~V _{CC}	V
Operating temperature	T _{opr}	-40~85	°C
		0~20 (V _{CC} = 1.8 V, 2.5 V ± 0.2 V)	ns/V
Input rise and fall time	dt/dv	0~10 (V _{CC} = 3.3 V ± 0.3 V)	
		$0~5~(V_{CC} = 5.5~V \pm 0.5~V)$	

Note: Data retention only

Electrical Characteristics

DC Characteristics

Characteristics Sy		Cumbal	rymbol Test Condition			Ta = 25°C			Ta = -40~85°C		Unit
		Symbol			V _{CC} (V)	Min	Тур.	Max	Min	Max	Unit
	.,			1.8	0.75 × V _{CC}	_	_	0.75 × V _{CC}	_		
Input voltage	High level	V _{IH}	_		2.3~5.5	0.7 × V _{CC}	_	_	0.7 × V _{CC}	_	V
Input voltage			_		1.8	—		0.25 × V _{CC}		0.25 × V _{CC}	
	Low level	V _{IL}			2.3~5.5	_	_	0.3 × V _{CC}	_	0.3 × V _{CC}	
					1.8	1.7	1.8	_	1.7	_	
				I _{OH} = -100 μA	2.3	2.2	2.3	_	2.2	_	
				ΙΟΗ = – 100 μΑ	3.0	2.9	3.0	_	2.9	_	
	High level	V	V _{IN} = V _{IH} or V _{IL}		4.5	4.4	4.5	_	4.4	_	
	nigii ievei	V _{OH}		$I_{OH} = -8 \text{ mA}$	2.3	1.9	2.15	_	1.9	_	
				$I_{OH} = -16 \text{ mA}$	3.0	2.4	2.8	_	2.4	_	
Output walkana			$I_{OH} = -24 \text{ mA}$	3.0	2.3	2.68	_	2.3	_	V	
			$I_{OH} = -32 \text{ mA}$	4.5	3.8	4.2	_	3.8	_		
Output voltage					1.8	_	0	0.1		0.1	V
			I _{OL} = 100 μA	2.3	_	0	0.1		0.1		
		İ	$V_{IN} = V_{IH}$	ΙΟΣ = 100 μΑ	3.0	_	0	0.1	_	0.1	-
	Low level	V _{OL}			4.5	_	0	0.1	_	0.1	
	LOW level	VOL		$I_{OL} = 8 \text{ mA}$	2.3	_	0.1	0.3	_	0.3	
				$I_{OL} = 16 \text{ mA}$	3.0	_	0.15	0.4		0.4	1
			$I_{OL} = 24 \text{ mA}$	3.0	_	0.22	0.55	_	0.55		
			$I_{OL} = 32 \text{ mA}$	4.5	_	0.22	0.55	_	0.55		
Input leakage curre	nput leakage current I _{IN} V _{IN} = 5.5 V or GND		0~5.5	_	_	±1	_	±10	μА		
3-state output off-s	tate current	I _{OZ}	$ V_{IN} = V_{IH} \text{ or } V_{IL}, $ $ V_{OUT} = 0 \sim 5.5 \text{ V} $		1.8~5.5	_		±1		±10	μА
Power off leakage	current	loff	OFF V _{IN} or V _{OUT} = 5.5 V		0.0	_		1	_	10	μΑ
Quiescent supply current I _{CC} V _{IN} = 5.5 V or GND		5.5	_		2	_	20	μΑ			

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AC Characteristics (unless otherwise specified, Input: $t_r = t_f = 3$ ns)

Characteristics	Cymahal	Symbol Test Condition		Ta = 25°C		Ta = -40~85°C		- Unit	
Characteristics Symbo		rest Condition	V _{CC} (V)	Min	Тур.	Max	Min	Max	Unit
		$C_L = 15 \text{ pF}, R_L = 1 \text{ M}\Omega$	1.8	2.0	5.3	11.0	2.0	11.5	
			2.5 ± 0.2	8.0	3.4	7.5	0.8	8.0	
Propagation delay time	t _{pLH}		3.3 ± 0.3	0.5	2.5	5.2	0.5	5.5	ne
Fropagation delay time	t _{pHL}		5.0 ± 0.5	0.5	2.1	4.5	0.5	4.8	ns ns
		C: - 50 pE P: - 500 O	3.3 ± 0.3	1.5	3.2	5.7	1.5	6.0	
		$C_L = 50 \text{ pF}, R_L = 500 \Omega$	5.0 ± 0.5	0.8	2.6	5.0	0.8	5.3	
Output enable time		$C_{I} = 50 \text{ pF}, R_{I} = 500 \Omega$	1.8	2.0	7.0	12.5	2.0	13.0	- ns
	t _{pZL}		2.5 ± 0.2	1.5	4.6	8.5	1.5	9.0	
	t _{pZH}	OL = 30 pr , NL = 300 12	3.3 ± 0.3	1.5	3.5	6.2	1.5	6.5	
			5.0 ± 0.5	8.0	2.8	5.5	0.8	5.8	
Output disable time			1.8	2.0	5.4	11.0	2.0	12.0	
	t _{pLZ}	$C_L = 50 \text{ pr}, R_L = 500 \Omega$	2.5 ± 0.2	1.5	3.5	8.0	1.5	8.5	- ns
	t _{pHZ}		3.3 ± 0.3	1.0	2.8	5.7	1.0	6.0	
			5.0 ± 0.5	0.5	2.1	4.7	0.5	5.0	
Input capacitance	C _{IN}	_	0~5.5	_	4			_	pF
Power dissipation	Coo	(Noto)	3.3		20			_	pF
capacitance	OPD	C _{PD} (Note)		_	27	_	_	_	ρi

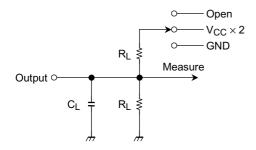
Note: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

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Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$

AC Characteristics Measurement Circuit

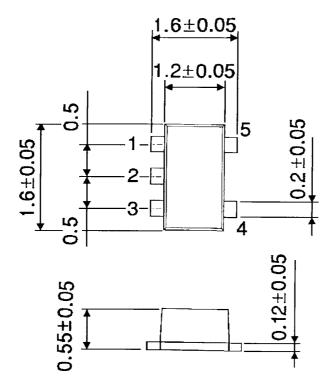


Characteristics	Switch
t _{pLH} , t _{pHL}	Open
t_{pLZ} , t_{pZL}	$V_{CC} \times 2$
t _{pHZ} , t _{pZH}	GND

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Package Dimensions

SON5-P-0.50 Unit: mm



Weight: 0.003 g (typ.)

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000707EBA

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